Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/585,387	JIANZHENG, BIAN	
Examiner	Art Unit	
Michael P. Ferguson	3679	

SEARCHED					
Class	Subclass	Date	Examiner		
403 {	252,254, 256,257, 264,322.1,	10/9/2007	MPF		
	323,409.1				
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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